

Keithley Instruments 28775 Aurora Road Cleveland, Ohio 44139 1-800-935-5595 tek.com/keithley

7-1/2 Digit Sampling Multimeter Specifications

SPECIFICATION CONDITIONS

This document contains specifications and supplemental information for the Model DMM7512 7¹/₂ Digit Sampling Multimeter instrument. Specifications are the standards against which the DMM7512 is tested. Upon leaving the factory, the DMM7512 meets these specifications. Supplemental and typical values are nonwarranted, apply at 23 °C, and are provided solely as useful information. Measurement accuracies are specified at the DMM7512 terminals under these conditions:

- Temperature 23 °C ±5 °C, 5% to 60% relative humidity, noncondensing
- After a 4-hour warmup period
- 1 PLC or 5 PLC; for NPLC settings less than 1 PLC, add appropriate ppm of range for peak noise uncertainty from the <u>RMS noise table</u>
- Autozero enabled unless otherwise noted
- Remote sense operation or properly zeroed local operation
- Calibration period: One year or two years (calibration period may vary depending on customer requirements)
- T_{ACAL} = Ambient temperature of last automatic calibration
- T_{CAL} = Ambient temperature of last external calibration; factory calibration performed at 23 °C ±1 °C

DC VOLTAGE

Accuracy (input impedance auto)

| Range ¹ | Resolution | Input impedance | Accuracy ±[ppm of reading + ppm of range] | | | | | | |
|----------------------------|------------|-------------------------|--|----------------------------------|----------------------------------|----------------------------------|--------------------------------------|--|--|
| | | impedance | 24 hour T _{CAL} ±1 °C ² | 90 day T _{CAL} ±5 °C | 1 year T _{cal} ±5 °C | 2 year T _{CAL} ±5 °C | Temperature coefficient ³ | | |
| 100.00000 mV ⁴ | 10 nV | > 10 GΩ or 10 MΩ ±1% | 6 + 30 | 12 + 30 | 18 + 30 | 29 + 30 | 0.1 + 2.5 | | |
| 1.0000000 V ⁴ | 100 nV | > 10 GΩ or 10 MΩ ±1% | 4 + 2 | 9 + 5 | 15 + 5 | 26 + 5 | 0.1 + 0.5 | | |
| 10.000000 V ⁴ | 1 μV | > 10 GΩ or 10 MΩ ±1% | 2 + 0.7 | 9 + 1.2 | 14 + 1.2 | 22 + 1.2 | 0.1 + 0.05 | | |
| 100.00000 V ⁴ | 10 µV | 10 MΩ ±1% | 8 + 6 | [18 + 15] ⁵ | [22 + 15] ⁵ | [30 + 15] ⁵ | [0.15 + 0.1] ⁵ | | |
| | | | | 35 + 15 | 40 + 15 | 45 + 15 | 2.0 + 1 | | |
| 1000.0000 V ^{4,6} | 100 μV | 10 MΩ ±1% | 8 + 6 | [19 + 10] ⁵ | [23 + 10] ⁵ | [31 + 10] ⁵ | [0.15 + 0.1] ⁵ | | |
| | | | | 35 + 10 | 40 + 10 | 45 + 8 | 2.0 + 1 | | |

¹ 20% overrange on all ranges except 1% for 1000 V range.

² Relative to calibration accuracy.

 $^{^3}$ Add per degree from T_{CAL} \pm5 °C.

⁴ When properly zeroed using the Rel function with external cables.

⁵ Specified within 30 days of autocalibration, T_{OPER} ±5 °C from T_{ACAL}.

⁶ For signal levels greater than 500 V, add 0.02 ppm/V to the ppm of the readings specification for measurements exceeding 500 V.

RMS NOISE (ADDITIONAL PEAK NOISE UNCERTAINTY)7

- Applies to ± ppm of range
- Peak noise uncertainty is included in DC specifications for ≥ 1 PLC
- . Add peak noise uncertainty to measurements for < 1 PLC
- Input impedance set to auto

Examples:

- 10 V at 0.006 PLC: 1.2 (from Accuracy table) + 11 (additional peak noise uncertainty) = 12.2 ppm of range
- 10 V at 1 PLC: 1.2 + 0 = 1.2 ppm of range

| NPLC | Digits | 100 mV | 1 V | 10 V | 100 V | 1000 V | | |
|------------------|--------|----------|-----------|-----------|-----------|-----------|--|--|
| 5 | 71⁄2 | 0.5 | 0.08 | 0.06 | 0.3 | 0.06 | | |
| 1 | 71⁄2 | 0.5 | 0.09 | 0.07 | 0.4 | 0.07 | | |
| 0.2 ⁸ | 61⁄2 | 2 (10) | 0.2 (1.6) | 0.1 (1.1) | 1.1 (9.4) | 0.1 (1) | | |
| 0.2 | 61⁄2 | 2 (12) | 0.2 (1.6) | 0.1 (1) | 1.1 (8.9) | 0.2 (1.1) | | |
| 0.06 | 51⁄2 | 3 (17) | 0.4 (2.7) | 0.3 (2.1) | 3 (17) | 0.3 (2.4) | | |
| 0.006 | 41⁄2 | 19 (95) | 3 (18) | 3 (15) | 34 (125) | 3 (18) | | |
| 0.0005 | 31⁄2 | 95 (480) | 48 (215) | 36 (170) | 173 (800) | 40 (205) | | |

DC voltage characteristics

| ADC linearity | 1.0 ppm of reading + 1.0 ppm of range |
|-------------------------------|---|
| Input impedance | 100 mV to 10 V ranges: Selectable > 10 GΩ II < 400 pF (auto) or 10 MΩ ±1% (10 MΩ) 100 V to 1000 V ranges: 10 MΩ ±1% |
| Input bias current | < 50 pA at 23 °C under the following conditions: Autozero off or input impedance 10 $M\Omega$ |
| Common mode current | < 2.1 μA peak-peak in 1 MHz bandwidth < 100 nA peak-peak in 1 kHz bandwidth |
| Common mode voltage | 500 VPEAK LO terminal to chassis maximum |
| DC voltage autozero off error | For ±1 °C and ≤ 10 minutes, add ± (8 ppm of reading + 15 μ V) |

Specifications are subject to change without notice 2 of 15 WWW.Valuetronics.com

⁷ Noise values are based on 1000 readings with autozero on and using low thermal 4-wire short. V_{RMS} noise is typical. Additional peak noise is guaranteed.

⁸ With line sync on.

Normal mode rejection

For DC voltage, line frequency ±0.1%

| | 5 PLC | 1 PLC | ≤ 0.2 PLC | ≤ 0.01 PLC |
|---------------|--------|-------|-----------|------------|
| Line sync on | 110 dB | 90 dB | 45 dB | — |
| Line sync off | 60 dB | 60 dB | — | — |

Common mode rejection

For DC voltage and 100 Ω unbalanced in LO terminal

| NPLC | 5 | 1 | 0.2 | ≤ 0.2 |
|-----------|--------|--------|--------|-------|
| Line sync | On | On | On | Off |
| CMRR | 140 dB | 140 dB | 120 dB | 80 dB |

RESISTANCE

Enhanced accuracy (within 30 days of autocalibration, T_{OPER} ±5 °C from T_{ACAL})⁹

| Range ¹⁰ | Resolution | Test current ¹¹ | Accuracy ±[ppm of reading + ppm of range] | | | | |
|-------------------------------|------------|----------------------------|---|----------------------------------|----------------------------------|----------------------------------|---------------------------------------|
| | | (±5%) | 24 hour T _{CAL} ±1 °C ¹² | 90 day T _{CAL} ±5 °C | 1 year T _{CAL} ±5 °C | 2 year T _{CAL} ±5 °C | Temperature coefficient ¹³ |
| 1.0000000 Ω | 0.1 μΩ | 10 mA | 15 + 60 | 30 + 60 | 30 + 60 | 30 + 60 | 0.15 + 0.1 |
| 10.000000 Ω | 1 μΩ | 10 mA | 15 + 6 | 30 + 6 | 30 + 6 | 30 + 6 | 0.15 + 0.1 |
| 100.00000 Ω | 10 μΩ | 1 mA | 12 + 4 | 27 + 4 | 27 + 4 | 27 + 4 | 0.15 + 0.1 |
| 1.0000000 kΩ | 100 μΩ | 1 mA | 12 + 3 | 24 + 3 | 24 + 3 | 24 + 3 | 0.15 + 0.1 |
| 10.000000 kΩ ¹⁴ | 1 mΩ | 100 µA | 13 + 3 | 30 + 3 | 30 + 3 | 30 + 3 | 0.15 + 0.1 |
| 100.00000 kΩ ^{14,15} | 10 mΩ | 10 µA | 13 + 3 | 30 + 3 | 30 + 3 | 30 + 3 | 0.3 + 0.1 |
| 1.0000000 MΩ ^{14,16} | 100 mΩ | 10 µA | 14 + 3 | 30 + 4 | 30 + 4 | 30 + 4 | 0.7 + 0.1 |
| 10.000000 MΩ ¹⁷ | 1 Ω | 0.69 µA ∥ 10 MΩ | 150 + 6 | 200 + 10 | 200 + 10 | 200 + 10 | 70 + 1 |
| 100.00000 MΩ ¹⁷ | 10 Ω | 0.69 µA ∥ 10 MΩ | 800 + 30 | 2000 + 30 | 2000 + 30 | 2000 + 30 | 385 + 1 |
| 1.0000000 GΩ ¹⁷ | 100 Ω | 0.69 μA ∥ 10 MΩ | 9000 + 100 | 9000 + 100 | 9000 + 100 | 9000 + 100 | 3000 + 1 |

⁹ Specifications are for 4-wire resistance, offset compensation on for $\leq 10 \text{ k}\Omega$ measurements, and offset compensation off for $\geq 10 \text{ k}\Omega$ measurements. 1 Ω range is 4-wire only. For 2-wire, with Rel, add 50 m Ω to ppm of range uncertainty. Without Rel and with Model 1756 test leads, add 100 m Ω to ppm of range uncertainty.

 ¹⁰ 20% overrange on all ranges.
 ¹¹ Test current with offset compensation off.

 $^{^{12}}$ Relative to calibration accuracy. 13 Add per degree from T_{CAL} ±5 °C. 14 Specifications are for external cable and load capacitance < 1 nF.

 $^{^{15}}$ For offset compensation on, add 10 ppm uncertainty to ppm of reading. 16 For 4-wire 1 MΩ, open lead detector on, add 10 ppm uncertainty to ppm of reading.

¹⁷ Specified for < 10% lead resistance mismatch in HI and LO.

| Range ¹⁹ | Resolution | Test current ²⁰ (±5%) | Accuracy ±[ppm of reading + ppm of range] | | | | | |
|-------------------------|------------|-------------------------------------|---|----------------------------------|----------------------------------|----------------------------------|---------------------------------------|--|
| | | | 24 hour T _{CAL} ±1 °C ²¹ | 90 day T _{CAL} ±5 °C | 1 year T _{CAL} ±5 °C | 2 year T _{CAL} ±5 °C | Temperature coefficient ²² | |
| 1 Ω | 0.1 μΩ | 10 mA | 15 + 60 | 40 + 60 | 50 + 60 | 70 + 60 | 2.5 + 5 | |
| 10 Ω | 1 μΩ | 10 mA | 15 + 6 | 40 + 6 | 50 + 6 | 70 + 6 | 2.5 + 0.5 | |
| 100 Ω | 10 μΩ | 1 mA | 12 + 4 | 35 + 4 | 47 + 4 | 65 + 4 | 5 + 0.25 | |
| 1 kΩ | 100 μΩ | 1 mA | 12 + 3 | 30 + 3 | 41 + 3 | 65 + 3 | 5 + 0.25 | |
| 10 kΩ ²³ | 1 mΩ | 100 µA | 10 + 3 | 30 + 3 | 42 + 3 | 65 + 3 | 2.5 + 0.25 | |
| 100 kΩ ^{23,24} | 10 mΩ | 10 µA | 13 + 3 | 38 + 3 | 50 + 3 | 65 + 3 | 5 + 1 | |
| 1 MΩ ^{23,25} | 100 mΩ | 10 µA | 14 + 3 | 38 + 5 | 50 + 5 | 65 + 5 | 5 + 1 | |
| 10 MΩ ²⁶ | 1 Ω | 0.69 μA II 10 MΩ | 150 + 6 | 200 + 10 | 400 + 10 | 600 + 12 | 70 + 1 | |
| 100 MΩ ²⁶ | 10 Ω | 0.69 μA II 10 MΩ | 800 + 30 | 2000 + 30 | 2000 + 30 | 2600 + 30 | 385 + 1 | |
| 1 GΩ ²⁶ | 100 Ω | 0.69 µA ∥ 10 MΩ | 9000 + 200 | 9000 + 200 | 13000 + 200 | 14000 + 200 | 3000 + 1 | |

Accuracy¹⁸

Resistance open circuit DC voltage²⁷

| Den re ¹⁹ | 0 wine | Offset compensation off | Offset compensation on |
|----------------------|--------|-------------------------|----------------------------|
| Range ¹⁹ | 2-wire | 4-wire | 4-wire |
| 1 Ω | _ | 9.2 V | 9.5 V |
| 10 Ω | 9.2 V | 9.2 V | 9.5 V |
| 100 Ω, 1 kΩ | 14.0 V | 14.2 V | 14.3 V |
| 10 kΩ | 9.5 V | 9.5 V | 9.5 V |
| 100 kΩ, 1 MΩ | 12.7 V | 14.3 V | 14.3 V (100 kΩ range only) |
| 10 MΩ to 1 GΩ | 6.9 V | 6.9 V | - |

¹⁸ Specifications are for 4-wire resistance, offset compensation on for ≤10 kΩ measurements, and offset compensation off for ≥10 kΩ measurements. 1 Ω range is 4-wire only. For 2-wire, with Rel, add 50 mΩ to ppm of range uncertainty. Without Rel and with Model 1756 test leads, add 100 mΩ to ppm of range uncertainty.

¹⁹ 20% overrange on all ranges.

²⁰ Test current with offset compensation off.

²¹ Relative to calibration accuracy.

 $^{^{22}}$ Add per degree from T_{CAL} ±5 °C.

²³ Specifications are for external cable and load capacitance < 1 nF.

²⁴ For offset compensation on, add 10 ppm of uncertainty to ppm of reading.

 $^{^{25}}$ For 4-wire, 1 MΩ, open lead detection on, add 10 ppm uncertainty to ppm of reading.

²⁶ Specified for < 10% lead resistance mismatch in HI and LO.

²⁷ Open circuit voltage is typical, measured from input HI to LO, SHI and SLO open. For 1 Ω to 1 MΩ ranges using an external digital multimeter (DMM) set to 10 MΩ input impedance; for 10 MΩ to 1 GΩ ranges, set external DMM to >10 GΩ input impedance.

Specifications are subject to change without notice

4-wire ohms (\leq 10 k Ω) offset compensation on

RMS NOISE (ADDITIONAL PEAK NOISE UNCERTAINTY)²⁸

- Applies to ± ppm of range
- Peak noise uncertainty is included in DC specifications for ≥ 1 PLC
- Add peak noise uncertainty to measurements for < 1 PLC

Examples:

- 1 kΩ at 0.006 PLC: 3 (from Accuracy table) + 26 (additional peak noise uncertainty) = 29 ppm of range
- 1 kΩ at 1 PLC: 3 + 0 = 3 ppm of range

| NPLC | Digits | 1Ω | 10 Ω | 100 Ω | 1 kΩ | 10 kΩ | | |
|--------|--------|-------------|-----------|-----------|-----------|-----------|--|--|
| 5 | 71⁄2 | 2.8 | 0.3 | 0.3 | 0.07 | 0.3 | | |
| 1 | 71⁄2 | 4.2 | 0.4 | 0.4 | 0.12 | 0.5 (2) | | |
| 0.229 | 6½ | 30 (160) | 3 (13) | 3 (13) | 0.4 (2.6) | 1.2 (8.2) | | |
| 0.2 | 61/2 | 50 (250) | 5 (22) | 5 (22) | 0.6 (3.2) | 1.2 (8.3) | | |
| 0.06 | 51/2 | 115 (546) | 11 (54) | 12 (56) | 1.1 (6.6) | 3 (18) | | |
| 0.006 | 41⁄2 | 397 (2144) | 40 (215) | 38 (216) | 6 (34) | 15 (78) | | |
| 0.0005 | 31⁄2 | 1767 (9333) | 177 (933) | 183 (954) | 85 (406) | 89 (456) | | |

2-wire ohms

RMS NOISE (ADDITIONAL PEAK NOISE UNCERTAINTY)28

- Applies to ± ppm of range
- Peak noise uncertainty is included in DC specifications for ≥ 1 PLC
- Add peak noise uncertainty to measurements for < 1 PLC

Examples:

- 10 kΩ at 0.006 PLC: 3 (from Accuracy table) + 5 (50 mΩ with Rel) + 43 (additional peak noise uncertainty) = 51 ppm of range
- 10 kΩ at 1 PLC: 3 + 5 + 0 = 8 ppm of range

| NPLC | Digits | 10 Ω | 100 Ω | 1 kΩ | 10 kΩ | | |
|--------|--------|-----------|-----------|-----------|------------|--|--|
| 5 | 71⁄2 | 1.1 | 0.8 (0.4) | 0.1 | 0.2 | | |
| 1 | 71⁄2 | 0.6 | 0.6 (0.4) | 0.09 | 0.4 (0.45) | | |
| 0.229 | 6½ | 2 (17) | 2 (10) | 0.2 (1.5) | 0.8 (6.3) | | |
| 0.2 | 6½ | 2 (17) | 2 (14) | 0.3 (1.6) | 0.8 (6.4) | | |
| 0.06 | 51⁄2 | 5 (29) | 6 (32) | 0.4 (3.7) | 2 (12) | | |
| 0.006 | 41⁄2 | 25 (114) | 21 (119) | 3 (21) | 9 (50) | | |
| 0.0005 | 31/2 | 103 (517) | 109 (536) | 56 (219) | 55 (283) | | |

²⁹ With line sync on.

²⁸ Noise values are based on 1000 readings with autozero on and using low thermal 4-wire short. RMS noise is typical. Additional peak noise is guaranteed.

Resistance characteristics

| Maximum 4-wire ohms lead resistance | $5~\Omega$ per lead for 1 Ω range, 10% of range per lead for 10 Ω to 1 k Ω ranges; 1 k Ω per lead for all other ranges | | |
|--|--|--|--|
| Offset compensation Selectable on 4-wire, 1 Ω to 100 k Ω ranges | | | |
| Open lead detector | Default is off | | |
| Autozero off error | For 2-wire ohms, ±1 °C and ≤ 10 minutes, add ±(8 ppm of reading) and 1.5 m Ω for 10 Ω range, 15 m Ω for 100 Ω and 1 k Ω ranges, 150 m Ω for 10 k Ω range, 1.5 Ω for 100 k Ω range, and 15 Ω for all other ranges | | |
| | For 4-wire ohms, $\pm 1 \text{ °C}$ and $\leq 10 \text{ minutes}$, add $\pm (8 \text{ ppm of reading})$ | | |
| Input current limit | For signals with a magnitude of +12 V to +40 V or -12 V to -40 V: ±13 mA source or sink, typical | | |
| | For signals with a magnitude of greater than +40 V or -40 V: \pm 1.3 mA source or sink, typical | | |

DC CURRENT

Enhanced accuracy (within 30 days of autocalibration, TOPER ±5 °C from TACAL)

| Range ³⁰ | Resolution | solution Maximum burden voltage | Accuracy ±[ppm of reading + ppm of range] | | | | | |
|---------------------|------------|---------------------------------------|---|----------------------------------|----------------------------------|----------------------------------|---------------------------------------|--|
| | | | 24 hour T _{CAL} ±1 °C ³¹ | 90 day T _{CAL} ±5 °C | 1 year T _{CAL} ±5 °C | 2 year T _{CAL} ±5 °C | Temperature coefficient ³² | |
| 10.000000 μA | 1 pA | 15 mV | 30 + 30 | 75 + 30 | 75 + 30 | 75 + 30 | 0.15 + 0.1 | |
| 100.00000 μA | 10 pA | 15 mV | 20 + 5 | 60 + 9 | 60 + 9 | 60 + 9 | 0.15 + 0.1 | |
| 1.0000000 mA | 100 pA | 15 mV | 30 + 5 | 60 + 9 | 60 + 9 | 60 + 9 | 0.15 + 0.1 | |
| 10.000000 mA | 1 nA | 20 mV | 40 + 5 | 60 + 9 | 60 + 9 | 60 + 9 | 0.15 + 0.1 | |
| 100.00000 mA | 10 nA | 200 mV | 50 + 18 | 150 + 30 | 150 + 30 | 150 + 30 | 0.15 + 0.1 | |
| 1.0000000 A | 100 nA | 400 mV | 150 + 50 | 400 + 50 | 400 + 50 | 400 + 50 | 0.15 + 0.1 | |
| 3.000000 A | 1 μA | 1300 mV | 200 + 40 | 400 + 40 | 400 + 40 | 400 + 40 | 0.15 + 0.1 | |

Accuracy

| | | Maximum | | Accuracy ±[ppm of reading + ppm of range] | | | | | |
|---------------------|------------|-------------------|---|---|----------------------------------|----------------------------------|---------------------------------------|--|--|
| Range ³⁰ | Resolution | burden voltage | 24 hour T _{CAL} ±1 °C ³¹ | 90 day T _{CAL} ±5 °C | 1 year T _{CAL} ±5 °C | 2 year T _{CAL} ±5 °C | Temperature coefficient ³² | | |
| 10.000000 μA | 1 pA | 15 mV | 30 + 30 | 100 + 30 | 125 + 40 | 175 + 50 | 10 + 8 | | |
| 100.00000 μA | 10 pA | 15 mV | 20 + 5 | 75 + 12 | 100 + 15 | 150 + 20 | 10 + 3 | | |
| 1.0000000 mA | 100 pA | 15 mV | 30 + 5 | 75 + 12 | 100 + 15 | 150 + 20 | 10 + 3 | | |
| 10.000000 mA | 1 nA | 20 mV | 40 + 5 | 75 + 12 | 100 + 15 | 150 + 20 | 10 + 3 | | |
| 100.00000 mA | 10 nA | 200 mV | 50 + 18 | 300 + 30 | 400 + 30 | 500 + 30 | 50 + 5 | | |
| 1.0000000 A | 100 nA | 400 mV | 150 + 50 | 400 + 50 | 450 + 50 | 500 + 50 | 10 + 10 | | |
| 3.000000 A | 1 μA | 1300 mV | 200 + 40 | 400 + 40 | 450 + 40 | 500 + 40 | 10 + 10 | | |

 ³⁰ 20% overrange supported for all ranges except for 3 A, which is 1% supported.
 ³¹ Relative to calibration accuracy.

³² Add per degree from $T_{CAL} \pm 5$ °Ć.

RMS NOISE (ADDITIONAL PEAK NOISE UNCERTAINTY)33

- Applies to ± ppm of range
- Peak noise uncertainty is included in DC Specifications for PLC ≥ 1
- Add peak noise uncertainty to measurements for PLC < 1

Examples:

1 mA at 0.006 PLC: 9 (from Accuracy table) + 20 (additional peak noise uncertainty) = 29 ppm of range

1 mA at 1 PLC: 9 + 0 = 9 ppm of range

| NPLC | Digits | 10 µA | 100 µA | 1 mA | 10 mA | 100 mA | 1 A | 3 A |
|-------------------|--------|------------|----------|-----------|-----------|-----------|----------|-----------|
| 5 | 71⁄2 | 0.15 | 0.14 | 0.09 | 0.1 | 0.3 | 0.3 | 0.2 |
| 1 | 71⁄2 | 0.4 | 0.13 | 0.1 | 0.1 | 0.5 | 0.5 | 0.3 |
| 0.2 ³⁴ | 61⁄2 | 0 (220) | 0 (23) | 0.2 (3.4) | 0.2 (1.6) | 2 (10) | 2 (11) | 0.7 (4.6) |
| 0.2 | 61⁄2 | 120 (260) | 12 (26) | 1.2 (3.8) | 0.3 (1.8) | 1.9 (9.8) | 2 (10) | 0.8 (5) |
| 0.06 | 51⁄2 | 130 (280) | 12 (29) | 1.3 (5.6) | 0.4 (3.9) | 2 (14) | 2 (14) | 1.2 (7.7) |
| 0.006 | 41⁄2 | 130 (350) | 14 (42) | 3 (20) | 2 (20) | 4 (30) | 4 (31) | 7 (51) |
| 0.0005 | 31⁄2 | 260 (2110) | 30 (300) | 20 (150) | 20 (160) | 30 (190) | 30 (190) | 70 (510) |

DC current characteristics

| Range | 10 µA | 100 µA | 1 mA | 10 mA | 100 mA | 1 A | 3 A |
|---|--------|--------|-------|--------|--------|--------|--------|
| Effective internal shunt value ³⁵ | 1 kΩ | 100 Ω | 10 Ω | 1 Ω | 0.1 Ω | 0.1 Ω | 0.1 Ω |
| Autozero off error: For ± 1 °C and ≤ 10 minutes, add $\pm (8 \text{ ppm of reading } + \text{ range error})$ | 150 pA | 1.5 nA | 15 nA | 150 nA | 15 μA | 150 μA | 150 μA |
| Overload recovery: | | | | | | | |
| For each additional sustained amp beyond ± 1.5 A, add the following initial ppm of range error until thermally settled after overload recovery | 15,500 | 1800 | 150 | 150 | 6500 | 200 | _ |

TEMPERATURE

4-wire RTD or 3-wire RTD

Types: 100 Ω platinum PT100, D100, F100, PT385, PT3916; or user-configurable 0 Ω to 10 k Ω

| Туре | Range | Resolution | Accuracy ± °C | |
|--------------------------|-------------------|------------|------------------------|---------------------------------------|
| | | | 2 year | Temperature coefficient ³⁶ |
| | | | T _{CAL} ±5 °C | |
| 4-wire RTD | -200 °C to 400 °C | 0.01 °C | 0.09 °C | 0.003 °C /°C |
| 3-wire RTD ³⁷ | -200 °C to 400 °C | 0.01 °C | 0.75 °C | 0.003 °C /°C |

³³ Noise values are based on 1000 readings with autozero on and AMPS terminal open. RMS noise is typical. Additional peak noise is quaranteed

guaranteed. ³⁴ With line sync on.

³⁵ Values are typical and guaranteed by design.

 $^{^{36}}$ Add per degree from $T_{CAL}\pm 5~^{o}C;$ specifications without autocalibration.

³⁷ For 3-wire RTD, accuracy is for < 0.1 Ω lead resistance mismatch for input HI and LO. Add 0.25 °C/ 0.1 Ω of HI-LO lead resistance mismatch.

Thermistor

Types: 2.252 k Ω , 5 k Ω , and 10 k Ω

| Туре | Range | Resolution | Accuracy ± °C | |
|------------|-------------------|------------|----------------------------------|---------------------------------------|
| | | | 2 year T _{caL} ±5 °C | Temperature coefficient ³⁶ |
| Thermistor | -80 °C to +150 °C | 0.01 °C | 0.08 °C | 0.002 °C /°C |

Thermocouple

Types: B, E, J, K, N, R, S, T

| Туре | Range | Resolution | Accuracy ± °C | |
|------|---------------------|------------|--|--|
| | | | 2 year T _{CAL} ±5 °C ³⁸ Simulated reference junction | Temperature coefficient ³⁶ |
| В | 350 °C to +1820 °C | 0.1 °C | 0.9 °C | 0.03 °C/°C |
| E | −200 °C to +1000 °C | 0.001 °C | 0.4 °C | 0.03 °C/°C |
| J | −200 °C to +760 °C | 0.001 °C | 0.4 °C | 0.03 °C/°C |
| К | −200 °C to +1372 °C | 0.001 °C | 0.4 °C | 0.03 °C/°C |
| Ν | −200 °C to +1300 °C | 0.001 °C | 0.4 °C | 0.03 °C/°C |
| R | 0 °C to +1768 °C | 0.1 °C | 0.9 °C | 0.03 °C/°C |
| S | 0 °C to +1768 °C | 0.1 °C | 0.9 °C | 0.03 °C/°C |
| Т | −100 °C to +400 °C | 0.001 °C | 0.4 °C | 0.03 °C/°C |

CONTINUITY

| Range ³⁹ | Resolution | Test | Open | Accuracy ±[ppm of reading + pr | om of range] |
|---------------------|------------|---------|--------------------|----------------------------------|---------------------------------------|
| | | current | circuit voltage | 2 year T _{CAL} ±5 °C | Temperature coefficient ⁴⁰ |
| 1.0000 kΩ | 100 mΩ | 1 mA | 14.0 V | 100 + 100 | 2.5 + 1 |

Continuity characteristics

| Continuity high limit User-selectable; default 10 Ω | |
|---|--|
|---|--|

 $^{^{38}}$ Exclusive of cold-junction errors. 39 Specifications exclude lead resistance. 40 Add per degree from T_{CAL} ±5 °C; specifications without autocalibration.

Diode

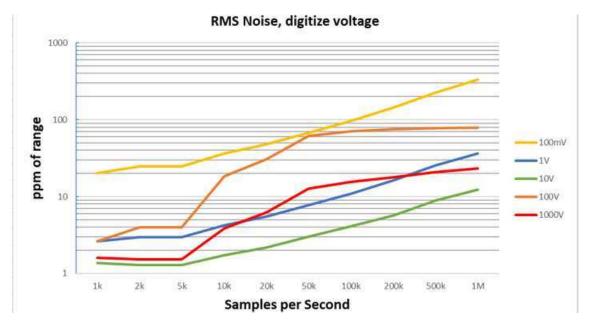
| Voltage | 5 | | Accuracy ±[ppm of reading + ppm of range] | | | | |
|--------------------------------|------|-----------------------|---|----------------------------------|----------------------------------|---------------------------------------|--|
| measure range ⁴¹ | | (selectable) | 90 day T _{CAL} ±5 °C | 1 year T _{CAL} ±5 °C | 2 year T _{CAL} ±5 °C | Temperature coefficient ⁴⁰ | |
| 10.000000 V | 1 μV | 10 μA / 100 μA / 1 mA | 20 + 5 | 30 + 5 | 45 + 5 | 2.5 + 1 | |

DIGITIZE VOLTAGE

Accuracy (input impedance auto)

| | | | Accuracy ±[p | Accuracy ±[ppm of reading + ppm of range] | | | | |
|-------------------------|--|----------------------|---|---|----------------------------------|---------------------------------------|--|--|
| Range ^{42,43} | Range ^{42,43} Resolution ⁴⁴ Input impe | | mpedance ⁴⁵ 90 day T _{CAL} ±5 °C | | 2 year T _{CAL} ±5 °C | Temperature coefficient ⁴⁶ | | |
| 100.000 mV | 1 μV | > 10 GΩ or 10 MΩ ±1% | 210 + 100 | 220 + 100 | 230 + 100 | 15 + 20 | | |
| 1.00000 V | 10 μV | > 10 GΩ or 10 MΩ ±1% | 110 + 75 | 120 + 75 | 130 + 75 | 15 + 20 | | |
| 10.0000 V | 0.1 mV | > 10 GΩ or 10 MΩ ±1% | 110 + 75 | 120 + 75 | 130 + 75 | 10 + 20 | | |
| 100.000 V ⁴⁷ | 1 mV | 10 MΩ ±1% | 110 + 75 | 120 + 75 | 130 + 75 | 15 + 20 | | |
| 1000.00 V ⁴⁸ | 10 mV | 10 MΩ ±1% | 110 + 75 | 120 + 75 | 130 + 75 | 10 + 20 | | |

DC-coupled additional noise uncertainty, typical⁴⁹



⁴¹ 20% overrange on all ranges.

⁴⁴ Power up default is 4½ digits.

⁴⁵ User-selectable.

- ⁴⁶ Add per degree from $T_{CAL} \pm 5\%$.
- ⁴⁷ For 100 V range, input impedance auto and without A_{CAL}, add 100 ppm of range additional uncertainty and 15 ppm/°C additional uncertainty for "of range" temperature coefficient for operation outside of T_{CAL} ±5 °C.
- ⁴⁸ For signal levels greater than 500 V, add 0.02 ppm/V to the ppm of the readings specification for measurements exceeding 500 V.
- ⁴⁹ Specified with aperture Auto and 4-wire short on input terminals. For 100 V range, input impedance 10 MΩ, multiply by 2.5. For all ranges and sample rate > 1 k, add an additional 3× RMS noise uncertainty to ppm of range.

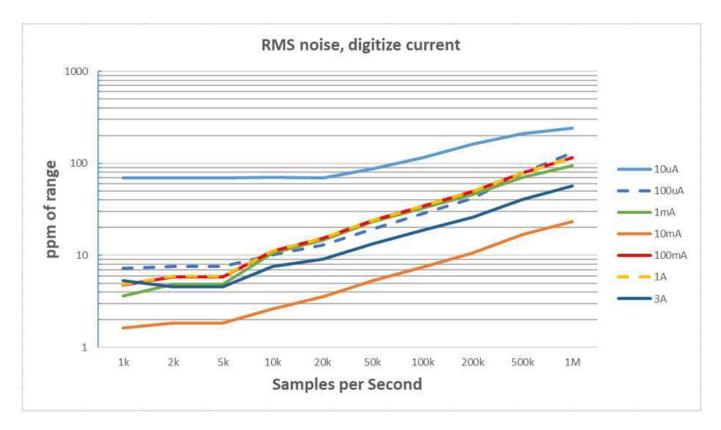
 ⁴² For DC coupling, 20% overrange for 100 mV to 100 V. For AC coupling, 500% overrange 100 mV to 100 V. 1% for 1000 V range DC coupling.
 ⁴³ Accuracy with sample rate 1 k per second, aperture auto, and 100 reading buffer average.

DIGITIZE CURRENT

DC accuracy⁵⁰

| | | Decedera | Accuracy ± [ppm of reading + ppm of range] | | | | |
|---------------------|--------------------------|-------------------|--|----------------------------------|----------------------------------|---------------------------------------|--|
| Range ⁵¹ | Resolution ³² | Burden voltage | 90 day T _{cal} ±5 °C | 1 year T _{CAL} ±5 °C | 2 year T _{CAL} ±5 °C | Temperature coefficient ⁵³ | |
| 10.0000 μA | 0.1 nA | 15 mV | 150 + 75 | 160 + 75 | 170 + 75 | 30 + 15 | |
| 100.000 μA | 1 nA | 15 mV | 150 + 75 | 160 + 75 | 170 + 75 | 30 + 15 | |
| 1.00000 mA | 10 nA | 15 mV | 150 + 75 | 160 + 75 | 170 + 75 | 30 + 15 | |
| 10.0000 mA | 100 nA | 20 mV | 150 + 75 | 160 + 75 | 170 + 75 | 30 + 15 | |
| 100.000 mA | 1 μA | 200 mV | 340 + 100 | 450 + 100 | 560 + 100 | 50 + 20 | |
| 1.00000 A | 10 µA | 400 mV | 400 + 110 | 500 + 110 | 600 + 110 | 50 + 25 | |
| 3.00000 A | 100 µA | 1300 mV | 650 + 150 | 900 + 150 | 900 + 150 | 50 + 25 | |

Additional noise uncertainty, typical⁵⁴



 $^{^{50}}$ Accuracy with sample rate 1 k per second, aperture auto, and 100 reading buffer average. 51 20% overrange on all ranges except 3.3% for 3 A range.

Specifications are subject to change without notice

www.valuetronics.com

 $^{^{52}}$ Power up default is 4½ digits. 53 Add per degree from T_{CAL} ±5 °C.

⁵⁴ Specified with aperture Auto and open input terminals. For all ranges and for ≥1 k sample rate, add an additional 3× RMS noise uncertainty to ppm of range.

DIGITIZER CHARACTERISTICS

| Maximum resolution | 18 bits |
|---------------------------------------|---|
| Measurement input coupling | DC (voltage only) |
| Sampling rate ⁵⁵ | Programmable 1 k through 1 million |
| Volatile sample memory with timestamp | 27.5 million |
| Minimum record time | 1 μs |
| Timestamp resolution | 1 ns with standard or full buffer style |
| | 1 μs with compact buffer style |
| Timestamp accuracy | With standard or full buffer style, 20 ns between adjacent readings, with total buffer time $< 2 \text{ s}$ |
| | With compact buffer style, 2 μs adjacent readings, with total buffer time < 2 s |
| Maximum record length | 8 million |

Typical reading rates, 60 Hz (50 Hz) operation^{56,57,58,59}

| | | Functions: DC voltage (10 V) 2-wire ohms (≤ 10 kΩ), DC current (1 mA) | | Functions: 4-wire ohms (≤ 1 kΩ) 4-wire / 3-wire RTD | | Functions: Thermistor | | Functions: Dry circuit (≤ 1 kΩ) | |
|--------|--------|--|------------------------------------|---|---------------------------------------|-------------------------------------|---------------------------------------|-------------------------------------|---------------------------------------|
| NPLC | Digits | Measure- ments into buffer | Measure- ments into computer | Measure -ments into buffer | Measure- ments into computer | Measure- ments into buffer | Measure- ments into computer | Measure -ments into buffer | Measure- ments into computer |
| 1 | 71⁄2 | 59.8 (49.8) | 58 (48) | 29 (24) | 28 (24) | 57 (48) | 57 (48) | 27 (23) | 26 (22) |
| 0.2 | 61⁄2 | 295 (240) | 250 (210) | 128 (109) | 119 (100) | 230 (200) | 230 (200) | 100 (89) | 96 (85) |
| 0.06 | 51/2 | 965 (810) | 950 (800) | 310 (280) | 315 (280) | 900 (750) | 900 (750) | 190 (180) | 190 (180) |
| 0.006 | 41⁄2 | 7500 (6700) | 7300 (6500) | 750 (730) | 740 (720) | 6800 (6000) | 6800 (6000) | 295 (290) | 295 (290) |
| 0.0005 | 31⁄2 | 26000 (26000) | 24000 (24000) | 860 (860) | 860 (860) | 18000 (18000) | 18000 (18000) | 310 (310) | 310 (310) |

Digitize, typical

| Sampling rate | Digits | Resolution | Measurements into computer ⁵⁹ |
|---------------|--------|------------|--|
| 10 kS/s | 51/2 | 18 | 9700 |
| 20 kS/s | 41/2 | 16 | 19000 |
| 50 kS/s | 41/2 | 16 | 44400 |
| 100 kS/s | 41/2 | 15 | 80000 |
| 1 MS/s | 31⁄2 | 12 | 108000 |

⁵⁵ Sample rate is not continuously adjustable. For valid discrete settings, see the Model DMM7512 Reference Manual.

 ⁵⁶ Reading speeds for autozero off, fixed range, autodelay off. Offset compensation off and open lead detector off where applicable.
 ⁵⁷ Buffer measurements: For < 0.2 PLC, multisample, single buffer transfer binary reading only.

⁵⁸ PC measurements: For 1 and 0.2 PLC single reading and single transfer to computer (USB).

⁵⁹ Reading rates using factory default operating conditions and autorange off, autodelay off. Speeds include measurement and data transfer out of the USB. ≥1000 readings with binary transfer over USB.

SYSTEM PERFORMANCE, TYPICAL

- Mode: 31/2 digit, autozero off, 0.0005 PLC, excludes measurement time
- Time includes function change from DC voltage or 2-wire ohms to listed function

| Function | Function change (ms) | Range change (ms) |
|--|----------------------|-------------------|
| DC voltage or 2-wire ohms (< 10 k Ω) | 6 | 1.3 |
| 4-wire ohms (< 10 kΩ) | 7 | 1.3 |
| DC current | 7 | 1.3 |
| Digitize voltage or current | 7 | 1.3 |

Ranges for function change times

Function change times apply to the ranges listed in the table below.

| Function | Range | |
|-----------------------|-----------------------|--|
| DC voltage | 10 V | |
| 2-wire or 4-wire ohms | 1 κΩ | |
| DC current | 1 mA | |
| Thermocouple | Use DC voltage rates | |
| Thermistor | Use 2-wire ohms rates | |

| Buffer transfer speed (binary) | Measurements into computer (per second) | | |
|--|---|--------|--|
| | USB | LAN | |
| Average for 1000 readings | 280000 | 270000 | |
| Average for 1000 readings with timestamp | 170000 | 140000 | |

TRIGGERING

| Time base accuracy | 25 ppm | |
|---|--|--|
| Trigger source | Analog DC voltage, DC current, or any system trigger | |
| Trigger coupling | DC | |
| Input trigger latency ^{60,61,62} | < 225 ns | |
| Input trigger jitter ^{60,61} | < 50 ns | |
| Sample period jitter ^{60,61} | < 1 ns | |

DMM triggers

| EXT TRIG IN and OUT | 0 V to 5 V logic signal input and output, TTL-compatible | |
|----------------------------------|--|--|
| EXT trigger latency (IN and OUT) | < 400 ns | |
| EXT trigger latency (IN or OUT) | < 200 ns (guaranteed by design) | |

 ⁶⁰ Guaranteed by design; for digital I/O only.
 ⁶¹ Stimulus command required to meet specifications.

⁶² If using trigger model, add 200 ns uncertainty.

Analog triggering⁶³

| Trigger characteristics | Voltage input | Current input |
|---|------------------|---------------|
| Input range | 100 mV to 1000 V | 10 μA to 3 A |
| Resolution | 0.05% | 0.05% |
| Basic accuracy (T _{ACAL} ±5 °C) ^{65,66} | 1% | 1% |

Analog level, edge, or window trigger types⁶⁴

Analog trigger latencies

| | Digital I/O | External |
|----------------|-----------------------|-----------------------|
| Positive logic | 800 ns + 40 ns jitter | 930 ns + 40 ns jitter |
| Negative logic | 800 ns + 40 ns jitter | 840 ns + 40 ns jitter |

Window filter and memory (buffer)

| Window filter size | 0 to 10% of reading, where 0 averages all readings | |
|----------------------------------|--|--|
| Memory | Up to 27.5 million timestamped readings with the compact buffer style, with additional memory available using an external USB flash drive | |
| Maximum Internal memory (buffer) | 27.5 million readings with the compact buffer style (6½-digit without formatting); 11 million readings with the standard or full buffer styles | |

⁶³ For DC coupled, the trigger level can be set up to 100% of measure range.

⁶⁴ Rising or falling edge triggering supported. Window trigger requires setting two independent levels.

⁶⁵ Trigger event occurs after the threshold crossing at a time determined by total trigger latencies.

⁶⁶ Accuracy specifications require user ACAL and are verified with level trigger amplitude set to 50% of range with a 100 Hz sine wave at 100% full scale of range. High frequency rejection is off. NPLC 0.0005 (DC voltage/DC current) or aperture 1 µs for digitize voltage or digitize current. Specified for fixed range, autozero off. For DC current and digitized DC current 3 A range, add an additional 2%.

Specifications are subject to change without notice

GENERAL INSTRUMENT SPECIFICATIONS

| Input protection | 1010 V DC all ranges and functions on HI and LO terminals; 350 V all ranges and functions on sense HI, sense LO terminals; 250 V rated current input terminal; fused 3 A range; current input terminals protected to 1 kV | |
|---------------------------|---|--|
| 3 A input fuse protection | 3.5 A, 1 kV fast blow type; Keithley part number DMM7510-FUSE-3A | |
| Common mode isolation | 500 V DC or AC VPEAK LO to chassis | |
| | All terminals > 10 G Ω , < 1000 pF any terminal to chassis | |
| Power line | Universal input, 100 V to 240 V | |
| Line frequency | 50 Hz or 60 Hz, automatically sensed at power-up | |
| Power consumption | 165 VA | |
| Operating environment | Specified for 0 °C to 50 °C, 70% relative humidity up to 35 °C; derate 3% relative humidity per °C, 35 °C to 50 °C | |
| Storage environment | -25 °C to 65 °C | |
| Environment | For indoor use only | |
| Altitude | Maximum 2000 m (6562 ft) above sea level | |
| Pollution degree | 2 | |
| Real time clock | Lithium battery backup (3+ years battery life) | |
| EMC | Conforms to European Union EMC Directive | |
| Safety | NRTL listed to UL61010-1 and CSA C22.2 No 61010-1; conforms with European Union Low Voltage Directive | |
| Vibration | MIL-PRF-28800F Class 3, Random | |
| Warm-up | 4 hours to rated accuracy | |
| Input signal connections | Rear safety banana jacks | |
| Cooling | Forced air, side intake, and rear exhaust | |
| Dimensions | Rack Mount: 44 mm high × 483 mm wide × 696 mm deep (1.7 in. × 19 in. × 27.41 in.) | |
| Shipping weight | 11.3 kg (25.0 lb) | |
| | | |

| Digital I/O | Connector | 9-pin female D | |
|----------------|----------------------------------|---|--|
| | 5 V power supply pin | Limited to 500 mA at > 4 V (solid-state fuse protected) | |
| | Lines | Six input/output, user-defined, for digital I/O or triggering | |
| | Input signal levels | 0.7 V (maximum logic low) | |
| | | 3.7 V (minimum logic high)-0.25 V (absolute minimum) | |
| | Input voltage limits | | |
| | | +5.25 V (absolute maximum) | |
| | Maximum source current | +2.0 mA at > 2.7 V (per pin) | |
| | Maximum sink current | -50 mA at 0.7 V (per pin, solid-state fuse protected) | |
| | Handler | User-defined start of test, end of test, four category bits | |
| Math functions | Rel, dB, Limit Test, Percentage, | 1/x, and mX + b | |

| Remote interface | LAN: RJ-45 connector, 10/100BT; Virtual Front Panel |
|------------------------|---|
| nemole interface | |
| | USB device (front panel, type B): 2.0 full speed, USBTMC compliant |
| | USB host (front panel, type A): USB 2.0, support for flash drives, FAT 32 |
| LXI compliance | LXI version 1.4 Core 2011 |
| Language | Embedded Test Script Processor (TSP) accessible from any host interface; responds to high-speed test scripts comprised of remote commands and statements (for example, branching, looping, math); able to execute high-speed test scripts stored in memory without host intervention; also SCPI (default command set) |
| Expansion interface | The TSP-Link expansion interface allows TSP-enabled instruments to trigger and communicate with each other. See the figure below. |
| | Node 1 Node 2 |
| | The DMM7512 has four TSP-Link connectors (two on each module) to make it easier to connect instruments in a sequence. |
| | Once instruments are interconnected through the TSP-Link expansion interface, a computer can access all of the resources of each instrument through the host interface of any TSP-Link instrument. A maximum of 32 TSP-Link nodes can be interconnected. Each module uses one TSP-Link node. |
| IP configuration | Static or DHCP (manual or automatic) |